

CD54/74AC564, CD54/74AC574 CD54/74ACT564, CD54/74ACT574

· ·	574 564
00	
01	-01 01
02	-02 02
D 3	03 03
04	
05	- 05 05
D6	- Q6 Q6
07	-07 07
₀Ē —	V _{CC} * 20
се	GND=10
•	9205-42424

Octal D-Type Flip-Flop, 3-State Positive-Edge-Triggered

CD54/74AC/ACT564 - Inverting CD54/74AC/ACT574 - Non-Inverting

Type Features:

- Buffered inputs
- Typical propagation delay: 6.5 ns @ V_{cc} = 5 V, T_A = 25°C, C_L = 50 pF

FUNCTIONAL DIAGRAM

The RCA-CD54/74AC564 and CD54/74AC574 and the CD54/74ACT564 and CD54/74ACT574 octal D-type, 3-state, positive-edge-triggered flip-flops use the RCA ADVANCED CMOS technology. The eight flip-flops enter data into their registers on the LOW-to-HIGH transition of the clock (CP). The Output Enable (\overline{OE}) controls the 3-state outputs and is independent of the register operation. When the Output Enable (\overline{OE}) is HIGH, the outputs are in the high-impedance state. The CD54/74AC/ACT564 and CD54/74AC/ACT564, however, has inverted outputs and the CD54/74AC/ACT574 has non-inverted outputs.

The CD74AC/ACT564 and CD74AC/ACT574 are supplied in 20-lead dual-in-line plastic packages (E suffix) and in 20-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Commercial (0 to 70°C); Industrial (-40 to +85°C); and Extended Industrial/Military (-55 to +125°C).

The CD54AC/ACT564 and CD54AC/ACT574, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

Family Features:

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST*/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply
- ± 24-mA output drive current
 - Fanout to 15 FAST* ICs
 - Drives 50-ohm transmission lines

*FAST is a Registered Trademark of Fairchild Semiconductor Corp.

TRUTH TABLE

	INPUTS	Ουτ	PUTS	
			564	574
ŌĒ	СР	Dn	Qn	Qn
L		н	L	н
L		L	н	L
L	L	Х	QO	QO
н	Х	Х	Z	Z

H = High level (steady state)

L = Low level (steady state)

X = Don't care

 $-\sqrt{1}$ = Transition from low to high level

- QO = The level of Q before the indicated steady-state input conditions were established
- \overline{QQ} = The level of \overline{Q} before the indicated steady-state input conditions were established.

Z = High impedance

This data sheet is applicable to the CD54/74AC574 and CD54/74ACT574. The CD54/74AC564 and CD54/74ACT564 were not acquired from Harris Semiconductor.

File Number 1948

MAXIMUM RATINGS, Absolute-Maximum Values:

1.

DC SUPPLY-VOLTAGE (Vcc)	±20 mA
DC OUTPUT DIODE CURRENT, I_{OK} (for $V_O < -0.5$ V or $V_O > V_{CC} + 0.5$ V) $\ldots \ldots \ldots$	
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, I_0 (for V ₀ > -0.5 V or V ₀	> < V _{cc} + 0.5 V) ±50 mA
DC Vcc or GROUND CURRENT (Icc or IgND)	±100 mA*
POWER DISSIPATION PER PACKAGE (Pp)	
For $T_A = -55$ to $\pm 100^{\circ}$ C (PACKAGE TYPE E)	
For T _A = +100 to +125°C (PACKAGE TYPE E)	Derate Linearly at 8 mW/°C to 300 mW
For $T_A = -55$ to $+70^{\circ}$ C (PACKAGE TYPE M)	
For T _A = +70 to +125°C (PACKAGE TYPE M)	. Derate Linearly at 6 mW/°C to 70 mW
OPERATING-TEMPERATURE RANGE (TA):	
STORAGE TEMPERATURE (T _{stg})	65 to +150°C
LEAD TEMPERATURE (DURING SOLDERING):	
At distance $1/16 \pm 1/32$ in. (1.59 \pm 0.79 mm) from case for 10 s maximum	+265°C
Unit inserted into PC board min. thickness 1/16 in. (1.59 mm) with solder contactin	

*For up to 4 outputs per device; add \pm 25 mA for each additional output.

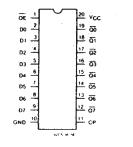
RECOMMENDED OPERATING CONDITIONS:

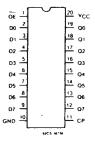
For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

	LIA	AITS	1000	
CHARACTERISTIC	MIN.	MAX.	UNITS	
Supply-Voltage Range, Vcc*:			T	
(For T _A = Full Package-Temperature Range)				
AC Types	1.5	5.5	V	
ACT Types	4.5	5.5	V	
DC Input or Output Voltage, Vi, Vo	0	Vcc	V	
Operating Temperature, T _A :	-55	+125	°C	
Input Rise and Fall Slew Rate, dt/dv			1	
at 1.5 V to 3 V (AC Types)	0	50	ns/V	
at 3.6 V to 5.5 V (AC Types)	0	20	ns/V	
at 4.5 V to 5.5 V (ACT Types)	0	10	ns/V	

*Unless otherwise specified, all voltages are referenced to ground.

TERMINAL ASSIGNMENT DIAGRAMS





CD54/74AC/ACT564

CD54/74AC/ACT574

STATIC ELECTRICAL CHARACTERISTICS: AC Series

,			•			AMBIEN	T TEMP	ERATUR	E (T _A) - °	С	1
CHARACTERISTI	CS	TEST CO	NDITIONS	V _{cc}	+	25	-40 1	lo +85	-55 t	o +125	
		. V, (V)	l _o (mA)	(Ÿ)	MIN.	MAX.	MÍN.	MAX.	MIN.	MAX.	
High-Level Input				1.5	1.2	-	1.2		1.2		1
Voltage	ViH			3	2.1	- 1	2.1	-	2.1		1 v 1
			+	5.5	3.85	- 1	3.85		3.85		1 .
Low-Level Input				1.5	_	0.3	- 1	0.3	_	0.3	1
Voltage	VIL			3		0.9	 	0.9	<u> </u>	0.9	l v
				5.5	-	1.65	_	1.65		1.65	1
High-Level Output	,		-0.05	1.5	1.4	- 1	1.4		1.4		
Voltage	Vон	Vін	-0.05	3	2.9		2.9	_	2.9		1
		or	-0.05	4.5	4.4	<u> </u>	4.4		4.4	_	1
		Vi⊾	-4	3	2.58	-	2.48	-	2.4		l v
		r	-24	4.5	3.94		3.8	_	3.7	-	1
		, , <i>\$</i>	-75	5.5	_		3.85		_	-	1
		#.* {	-50	5.5			-	-	3.85		1
Low-Level Output			0.05	1.5	-	0.1		0.1		0.1	<u> </u>
Voltage	Vol	ViH	0.05	3		0.1	_	0.1	_	0.1	1
		or	0.05	4.5	—	0.1	_	0.1	_	0.1	l v
		ViL	12	3	_	0.36	-	0.44		0.5	1
			24	4.5		0.36	—	0.44	_	0.5	
		5	75	5.5	_	_	_	1.65	_		
		#, * {	50	5.5		—	_	_	_	1.65	
Input Leakage Current	h	V _{cc} or GND		5.5		±0.1		±1		±1	μA
3-State Leakage Current	loz	V _{IH} or									
		V _{IL}									
		νι∟ 'Vo ≕		5.5		±0.5		±5		±10	μA
		V _{CC}		0.0	-	10.5		<u> </u>		, .	$\mu \wedge$
		or									
		GND				2					
Quiescent Supply Current, MSI	lcc	V _{cc} or GND	0	5.5		8		80		160	μA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. *Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

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STATIC ELECTRICAL CHARACTERISTICS: ACT Series

		5	· •			AMBIEN	Т ТЕМРЕ		E (T _A) - °	с	
CHARACTERISTICS		TEST CO	NDITIONS	V _{cc}	+25		5 -40 to +85		+85 -55 to +125		
		V, (V)	l _o (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input Voltage	ViH			4.5 to 5.5	2	_	2	_	2	-	v
Low-Level Input Voltage	ViL			4.5 to 5.5	_	0.8	_	0.8	-	0.8	v
High-Level Output		ViH	-0.05	4.5	4.4		4.4	-	4.4	_	<u> </u>
Voltage	V _{он}	or	-24	4.5	3.94	-	3.8	- 1	3.7	<u> </u>	
· · ·	-	V ^{IL} . 5	-75	5.5			3.85		—	-]
		#, * {	-50	5.5	[-	—		3.85	_]
Low-Level Output		ViH	0.05	4.5	— [·]	±0.1	—	±.1		±.1	
Voltage	Vol	or	24	4.5	_	0.36	-	0.44	—	0.5] v
		Vil j	75	5.5	—	_	—	1.65	—	-]
		#, * {	50	5.5		-	—	-	—	1.65]
Input Leakage Current	ե	V _{cc} or GND		5.5	_	±0.1	_	±1		±1	μA
3-State Leakage Current	loz	ViH or ViL									
		V _o = V _{cc} or GND		5.5		±0.5		±5		±10	μA
Quiescent Supply Current, MSI	Icc	V _{cc} or GND	0	5.5		8	_	80		160	μΑ
Additional Quiescent Current per Input P TTL Inputs High 1 Unit Load	Supply Pin ∆I _{cc}	Vcc-2.1		4.5 to 5.5	_	2.4	⁻	2.8	_	3	mA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

*Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

ACT INPUT LOADING TABLE

INPUT	UNIT LOADS*
D, OE	0.7
CP	1.17

*Unit load is Alcc limit specified in Static

Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

PREREQUISITE FOR SWITCHING: AC Series

						AMBIENT TEMPERATURE (T			
CHARACTERISTICS	SYMBOL	V _{cc} (V)		-40 to +85		-55 to +125			
· · · · · · · · · · · · · · · · · · ·		(¥)	MIN.	MAX.	MIN.	MAX.			
Clock Pulse Width	tw	1.5 3.3* 5†	44 4.9 3.5		50 5.6 4		ns		
Setup Time Data to Clock	tsu	1.5 3.3 5	2 2 2		2 2 2		ns		
Hold Time Data to Clock	t _H	1.5 3.3 5	2 2 2	— — —	2 2 2	 	ns		
Maximum Clock Frequency	fмах	1.5 3.3 5	11 101 143		10 89 125	-	MHz		

*3.3 V: min. is @ 3 V

†5 V: min. is @ 4.5 V

SWITCHING CHARACTERISTICS: AC Series; t,, t = 3 ns, C_L = 50 pF

			AMB	ENT TEMP	ERATURE (T _A) -° C	[
CHARACTERISTICS	SYMBOL	V _{cc} (V)		-40 to +85		-55 to +125	
		(*)	MIN.	MAX.	MIN.	MAX.	UNITS
Propagation Delays: Clock to Q AC574	tplh tphl	1.5 3.3* 5†	4 2.9	123 13.7 9.8	 3.8 2.7	135 15.1 10.8	ns
Clock to Q AC564	tplн tphl	1.5 3.3 5	 4.1 2.9	128 14.4 10.3		141 15.8 11.3	ns
Output Enable to Q, Q	tezi. tezh	1.5 3.3 5		165 19.2 13.2	 5.5 3.6	181 21.8 14.5	ns
Output Disable to Q, \overline{Q}	tplz tpнz	1.5 3.3 5	- 4.7 3.7	165 16.5 13.2	 4.5 3.6	181 18.1 14.5	ns
Power Dissipation Capacitance	CPD§		67	Тур.	67	Гур.	pF
Min. (Valley) V _{он} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See . Fig. 1	5	4 Typ. @ 25°C			v	
Max. (Peak) VoL During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Typ. @ 25°C		v		
Input Capacitance	Cı			10	_	10	pF
3-State Output Capacitance	Co			15		15	pF

*3.3 V: min. is @ 3.6 V

max. is @ 3 V

min. is @ 5.5 V †5 V: max. is @ 4.5 V

§CPD is used to determine the dynamic power consumption, per flip flop. $P_{D} = C_{PD} V_{CC}^{2} f_{i} + \Sigma V_{CC}^{2} f_{0} C_{L} \text{ where } f_{i} = \text{input frequency}$

- $f_0 =$ output frequency $C_L =$ output load capacitance
- Vcc = supply voltage.

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PREREQUISITE FOR SWITCHING: ACT Series

			AMBI	ENT TEMPE	RATURE (1	「∧) -°C	
CHARACTERISTICS	SYMBOL	V _{cc} (V)	-40 t	-40 to +85		-55 to +125	
		(*)	MIN.	MAX.	MIN.	MAX.	
Clock Pulse Width	tw	5†	3.9		4.5		ns
Setup Time Data to Clock	tsu	5	2		2		ns
Hold Time Data to Clock	t _H	5	2.6		3		ns
Maximum Clock Frequency	fmax	5	125		110		MHz

.

†5 V: min. is @ 4.5 V

SWITCHING CHARACTERISTICS: ACT Series; t,, t, = 3 ns, CL = 50 pF

			AMBI	ENT TEMPE	RATURE (Г _А) -°С	
CHARACTERISTICS	SYMBOL	V _{cc}	-40 t	o +85	-55 te	o +125	UNITS
		(V)	MIN.	MAX.	MIN.	MAX.	
Propagation Delays: Clock to Q ACT574	tрын tрыс	5†	2.9	10.2	2.8	11.2	ns
Clock to Q ACT564	t _{PLH} t _{PHL}	5	3	10.6	2.9	11.7	ns
Output Enable and Disable to Q ACT574	tplz tpнz tpzl tpzн	5	3.7	13.2	3.6	14.5	ns
Output Enable and Disable to Q ACT564	tplz tphz tpzl tpzh	5	3.7	13.2	3.6	14.5	ns
Power Dissipation Capacitance	C _{PD} §		67	Тур.	67	Тур.	pF
Min. (Valley) V _{он} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5	4 Typ. @ 25°C		v		
Max. (Peak) VoL During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5		1 Typ.	@_25°C		v
Input Capacitance	Cı			10		10	pF
3-State Output Capacitance	Co	_		15	I	15	pF

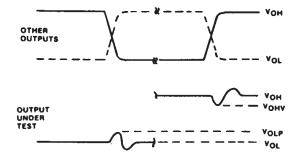
†5 V: min. is @ 5.5 V

max. is @ 4.5 V

 $\begin{aligned} & \label{eq:cp} \ensuremath{\S{C_{PD}}}\xspace is used to determine the dynamic power consumption, per flip flop. \\ & \ensuremath{P_{D}}\xspace = C_{PD} \ensuremath{V_{CC}}^2 f_i + \Sigma \ensuremath{V_{CC}}^2 f_0 \ensuremath{C_{L}}\xspace + \ensuremath{V_{CC}}\xspace \Delta I_{CC} \ensuremath{\text{where}}\xspace f_i = \ensuremath{\text{input}}\xspace f_i = \ensuremath{\text{output}}\xspace f_i = \ensure$

 $V_{cc} = supply voltage.$

PARAMETER MEASUREMENT INFORMATION



NOTES:

- 1. VOHY AND VOLP ARE MEASURED WITH RESPECT TO A GROUND REFERENCE NEAR THE OUTPUT UNDER TEST. 2. INPUT PULSES HAVE THE FOLLOWING CHARACTERISTICS:
- PRA ≤ 1 MHz, Ir = 3 ns, Ir = 3 ns, SKEW 1 ns. A.F. FIXTURE WITH 700-MH2 DESIGN RULES REQUIRED. IC SHOULD BE SOLDERED INTO TEST BOARD AND BYPASSED WITH 0.1 #F CAPACITOR. SCOPE AND PROBES REQUIRE 700-MH2 BANDWIDTH.

9205-42406

Fig. 1 - Simultaneous switching transient waveforms.

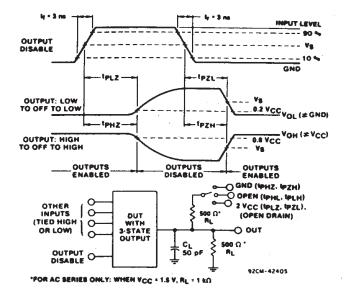
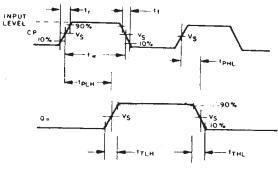
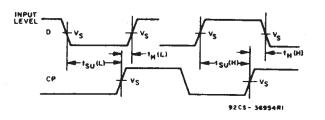


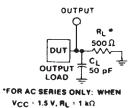
Fig. 2 - Three-state propagation delay waveforms and test circuit.







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9255 - 42389

	CD54/74AC	CD54/74ACT
Input Level	V _{cc}	3 V
Input Switching Voltage, Vs	0.5 V _{cc}	1.5 V
Output Switching Voltage, Vs	0.5 V _{cc}	0.5 V _{cc}

Fig. 3 - Propagation delays times and test circuit.

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15-Oct-2009

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD54AC574F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type
CD54ACT574F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type
CD74AC574E	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC574EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC574M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC574M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC574M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC574M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC574ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC574MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574E	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74ACT574EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74ACT574M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT574MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined. Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements

for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.



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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC574M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74ACT574M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC574M96	SOIC	DW	20	2000	346.0	346.0	41.0
CD74ACT574M96	SOIC	DW	20	2000	346.0	346.0	41.0

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



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